 Search Notes		

Application/Control No.	Applicant(s)/Patent under Reexamination
09/269,518	FENNER ET AL.
Examiner	Art Unit
Devin Hanan	3745

	SEARCHED				
Class	Subclass	Date	Examiner		
415	211.2				
416	185,186R				
	188, DIG5				
	186A				
415	218.1				
	219.1	3/9/2005	DH		
417	423.1				
	366	3/15/2005	DH		

INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner

SEARCH (INCLUDING SEAF)
	DATE	EXMR
consulted Chris Verdier on class 416, 415	3/9/2005	DH
consulted Chuck Freay on class 417	3/15/2005	DH